



Recombination Time in Drift-Diffusion Models of Graphene Field-Effect Transistors Pedro C. Feijoo, Ferney A. Chaves, D. Jiménez









Outline

- Introduction
- Mathematical model
- Results
- Conclusions





Recombination Time in Drift-Diffusion Models of Graphene Field-Effect Transistors

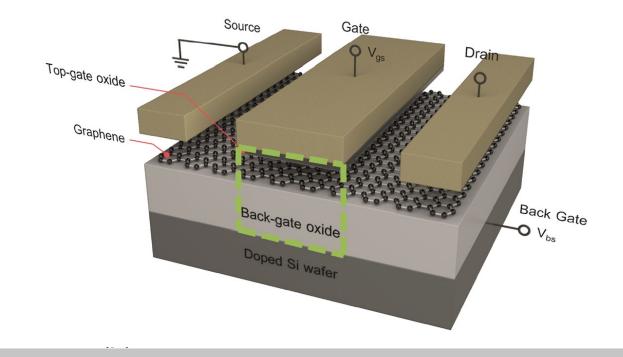
INTRODUCTION





Introduction

- Graphene Field-Effect Transistor (GFET)
 - High mobility and saturation velocity
 - Applications in radiofrequency and photonics



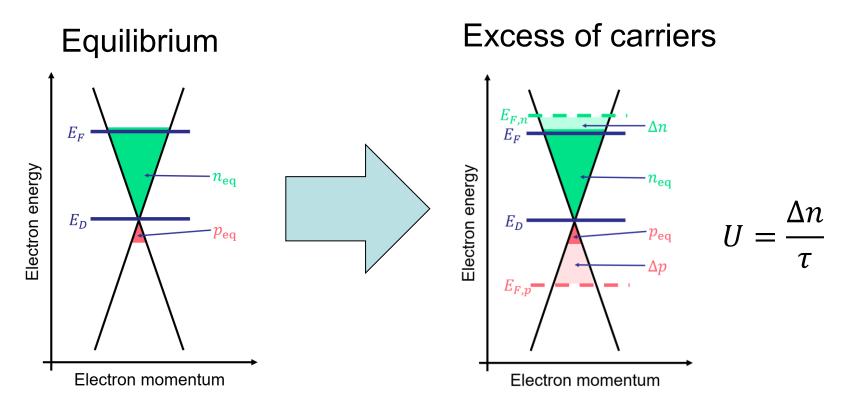




Introduction

Recombination time in graphene

 $\tau \approx 1 - 100 \text{ ps}$ have been reported







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MATHEMATICAL MODEL



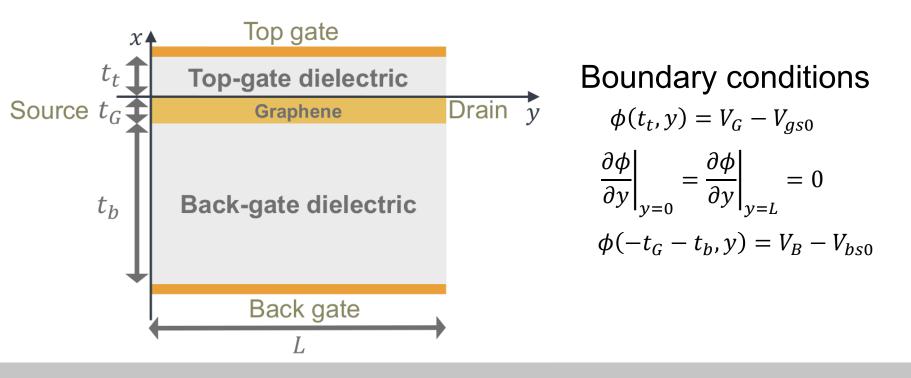


Mathematical model

Poisson's equation

$$\nabla \cdot [\epsilon(x, y) \nabla \phi(x, y)] = \rho_{\text{free}}(x, y)$$

 $\rho_{\text{free}}(x, y) = \frac{q[p(y) - n(y)]}{t_G}$

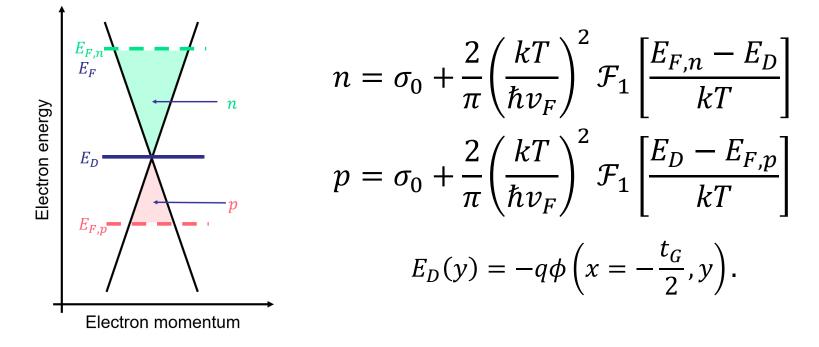






Mathematical model

Carrier concentration



Electron and hole concentrations are deduced from the linear dispersión relation and the Fermi-Dirac statistics.





Mathematical model

Current continuity equation

$$J_n(y) = n(y)\mu_n(y)\frac{dE_{F,n}(y)}{dy}$$
$$J_p(y) = p(y)\mu_p(y)\frac{dE_{F,p}(y)}{dy}$$

$$\frac{\mathrm{d}J_n(y)}{\mathrm{d}y} = qU(y)$$

$$\frac{\mathrm{d}J_p(y)}{\mathrm{d}y} = -qU(y)$$

$$J_{DS} = J_n(y) + J_p(y)$$

$$\mu_n(y) = \mu_p(y) = \mu(y) = \frac{\mu_{LF}}{\sqrt[\beta]{1 + \left(\frac{\mu_{LF}}{v_{sat}} \left| -\frac{\partial \phi}{\partial y} \right|_{x = -\frac{t_G}{2}} \right)^{\beta}}}$$

Boundary conditions $E_{F,n}(L) = E_{F,p}(L) = -qV_D$ $E_{F,n}(0) = E_{F,p}(0) = -qV_S$

Our model solves self-consistently Poisson's equation and current continuity.

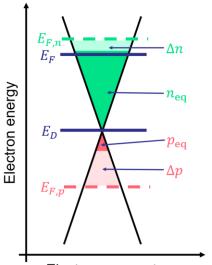




Mathematical model

Recombination model

$$\frac{\mathrm{d}J_n}{\mathrm{d}y} = -\frac{\mathrm{d}J_p}{\mathrm{d}y} = qU$$
$$U = \frac{\partial\Delta n}{\partial t} = \frac{\partial\Delta p}{\partial t} = -\frac{\Delta n}{\tau} = -\frac{n - n_{\mathrm{eq}}}{\tau}$$



We consider band-to-band recombinations and charge neutrality.

$$U \propto -\Delta n$$
 $\Delta p \approx \Delta n$

$$U = -\frac{n - n_{\rm eq}(n, p, E_D)}{\tau}$$

Electron momentum



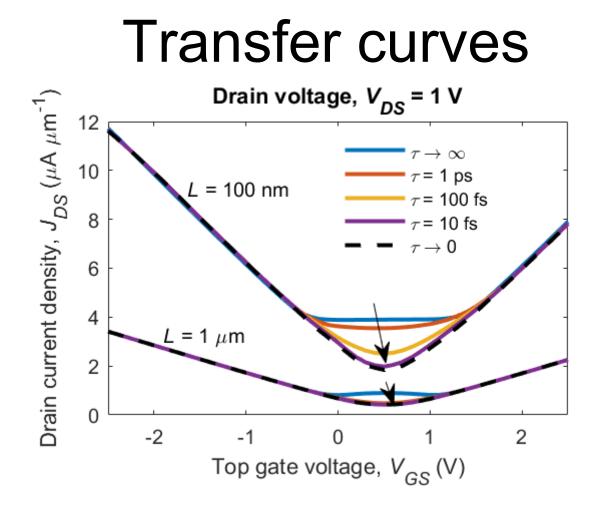


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RESULTS

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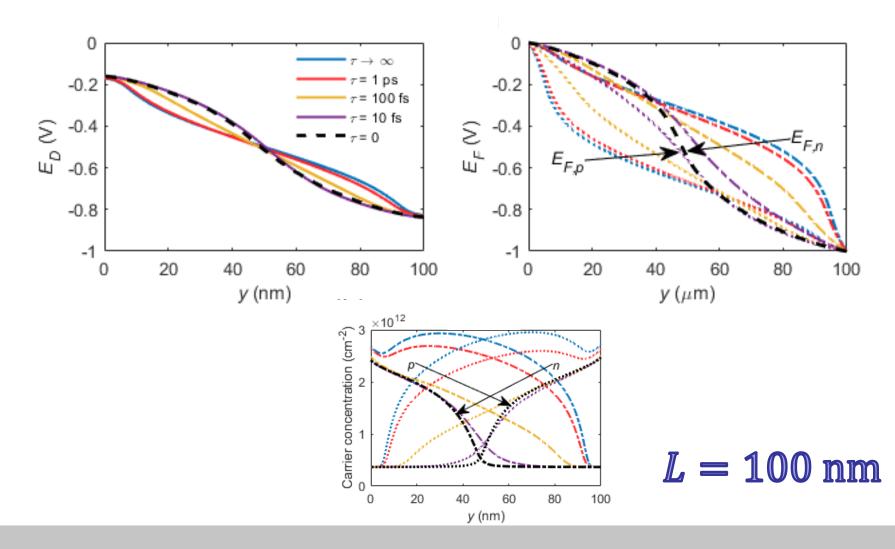


Recombination mainly affects at biases close to Dirac point.





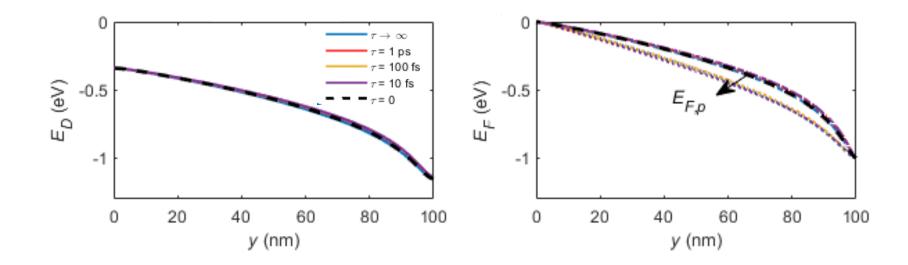
Dirac point: $V_{GS} = 0.5 \text{ V}; V_{DS} = 1 \text{ V}$







Far from Dirac point: $V_{GS} = 2 \text{ V}; V_{DS} = 1 \text{ V}$

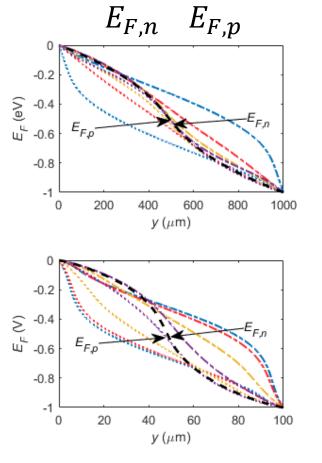


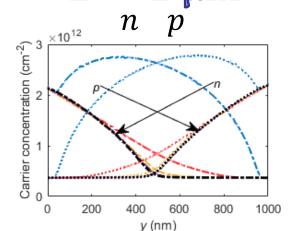


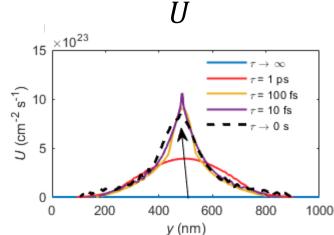


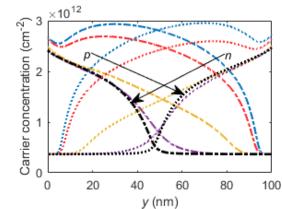


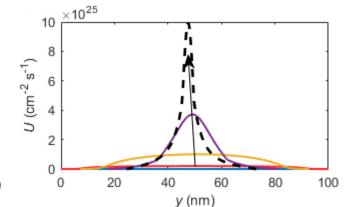
Different channel lengths $L = 1 \mu m$











L = 100 nm





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CONCLUSIONS





Conclusions

- Effect of recombination in GFETs. We considered band-to-band recombination with charge neutrality
- Recombination affects mainly around the Dirac bias, where charge transport is ambipolar
- For a 100 nm channel,
 - $\tau < 10 \text{ fs} \rightarrow \text{single quasi-Fermi level}$ approximation ($\tau \rightarrow 0 \text{ s}$)

 $-\tau > 1 \text{ ps} \rightarrow \text{null recombination rate } (U = 0)$

• These limits are larger for longer channels





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Thanks for your attention!